

Electrically Induced Bulk and Edge Excitations in the Fractional Quantum Hall Regime

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We apply a voltage pulse to electrically excite the incompressible region of a two-dimensional electron liquid in the $\nu = 2/3$ fractional quantum Hall state and investigate the collective excitations in both the bulk and edge via photoluminescence spectral energy shifts. Introducing an offset in the voltage pulse significantly enhances the excitation signal. Real-space and time-resolved measurements reveal the dynamics of the bulk excitations, with an estimated group velocity of approximately 3×10^4 m/s. These bulk excitations align well with the magnetoplasmon model. Because bulk and edge magnetoplasmons are composed of two polarization degrees of freedom of the gauge field, our results highlight a connection that could serve as a resource for their entanglement—similar to the polarization of a photon—and offer a novel approach to exploring solid-state analogs of quantum gravity.

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The quantum Hall effect is a phenomenon observed in a two-dimensional electron gas (2DEG) at low temperatures and under the influence of a strong magnetic field B . In this regime, the longitudinal resistance drops to zero while the Hall resistance becomes quantized. This occurs when the filling factor $\nu = n_e h / eB$, which represents the ratio of the electron density n_e to the magnetic flux quantum density $B / (h/e)$, is either an integer or a rational fraction [1,2]. Here, h and e denote the Planck constant and the elementary charge, respectively. The Hall resistance quantizes to discrete values of $h / \nu e^2$. The quantum Hall effect represents the first example of a topological insulator, characterized by a bulk energy gap and gapless edge [3]. Bulk excitations typically require energy above the gap, which, for the integer quantum Hall effect, corresponds to the cyclotron frequency $\omega_c = eB / m^*$, of the electron with an effective mass m^* . In the fractional quantum Hall (FQH) effect, collective neutral excitations known as magnetorotons have been both theoretically predicted [4] and experimentally observed through Raman scattering [5,6] and phonon absorption [7]. Recently, magnetorotons with wave numbers near zero have been experimentally

studied [8], attracting renewed interest due to their anticipated behavior as chiral gravitons with spin 2 [9,10].

In contrast to the bulk, the edge can be excited with infinitesimal energy due to the absence of an energy gap. Edge excitations propagate spatially along the edge over long distances with suppressed dissipation [11–14]. These edge excitations, known as “edge magnetoplasmons,” are characterized by nearly free propagation with a group velocity v_g , and their frequency is approximately linear in the wave vector k as $\omega(k) = v_g k$. The unique properties of the edge have inspired proposals for innovative applications, including quantum energy teleportation [13,15–17] and a quantum gravity simulator [17–20] that models an expanding universe in $(1+1)$ dimensions. Furthermore, the correlation between the bulk and the edge is of significant importance when considering a condensed matter analog of brane world scenario [21] in which the bulk corresponds to an extra dimension for the edge.

The bulk-edge correspondence suggests that both the bulk and the edge provide valuable insights into the quantum Hall effect. We focus on extracting complementary information from the bulk excitations of the $\nu = 2/3$ FQH state, where the edge modes are known to exhibit considerable complexity [22,23]. We intentionally excited the bulk by efficiently stimulating the edge using a voltage pulse applied to an electrode connected to both the edge and the bulk. Using a stroboscopic photoluminescence (PL) microscope [24,25], we captured the dynamics of these bulk excitations. Our results reveal that the primary bulk

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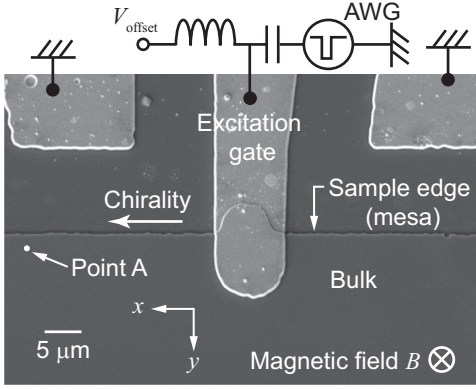


FIG. 1. Scanning electron microscope image of a typical device. The light and dark gray regions correspond to the deposited Au electrodes and GaAs surface, respectively. The excitation gate is connected to an arbitrary waveform generator (AWG) and a dc voltage source, which provides an offset voltage V_{offset} to the pulse. The two electrodes connected to the ground and the excitation gate form a coplanar waveguide.

excitations consist of magnetoplasmons, which are dynamical electromagnetic gauge fields tightly bound to the 2DEG under an external static magnetic field. Magnetoplasmons are intrinsically related to magnetorotons: the latter are derived from the lowest Landau level projection of the Hilbert space [4], while the former can be derived without this approximation [26]. Furthermore, the dispersion relation of magnetoplasmons is expressed as

$$\omega(k) = \omega_c + v_g k. \quad (1)$$

As will be shown later in Eq. (2), this v_g has a simple form that is determined solely by the quantized Hall resistance and the permittivity of GaAs. Additionally, we observed another type of bulk excitation with a velocity approximately an order of magnitude slower than the primary bulk excitation. This secondary excitation can be interpreted as a strain pulse [27] that represents the bulk counterpart of an edge mode carrying heat [28].

The measurements were conducted on a 15-nm GaAs/AlGaAs quantum well (QW). An $n+$ GaAs substrate served as a back gate electrode, allowing n_e in the QW to be controlled by applying a voltage, V_b , to the back gate. This configuration enables ν to be set to $2/3$ at various B . The horizontal line labeled as the sample edge in Fig. 1 corresponds to the ~ 250 -nm step of the mesa. The etched region in this image is located above this line, while the bulk region containing the 2DEG lies below this line. The excitation gate and the two ground pads (Fig. 1) were fabricated by evaporating Ti/Au over the GaAs surface. Scanning stroboscopic PL microscopy and spectroscopy (see Appendix A for more details) [24,25] were used to observe the bulk and edge responses to the incoming ac pulses transmitted through the excitation gate. All measurements were conducted at $\nu = 2/3$ and a temperature

$T = 40$ – 55 mK unless otherwise specified. The $\nu = 2/3$ FQH state exhibits a competition between the Zeeman and Coulomb energies, leading to a degeneracy between the spin-polarized (ferromagnetic) and unpolarized (nonmagnetic) phases at a critical magnetic field B_c . At B_c , a first-order phase transition occurs between these two phases [29–31], forming domains of these phases and their domain boundaries [31]. In our sample, B_c was determined to be approximately 7.5 T based on the B dependence of the PL spectrum [32] [see Fig. S2 in Supplemental Material (SM) [33] for details]. A voltage pulse was applied to the excitation gate using an AWG and a dc voltage source, connected via a bias tee (Fig. 1). This voltage pulse (Fig. 5) electrically excites electrons in both the edge and bulk.

To maximize the visibility of the edge excitation, we applied a voltage pulse with an offset V_{offset} and investigated its impact on the PL spectrum (Fig. 2). The measurement point (Point A in Fig. 1) was located $x = 25$ μm downstream from the excitation gate and $y = 2$ μm away from the sample edge (mesa). PL spectra were recorded by varying the time delay t between the voltage pulse and the laser pulse, with V_{offset} as a parameter. Regardless of the V_{offset} , the PL peak exhibited a distinct blueshift around $t \sim 0.5$ ns compared to the PL peak observed at $t < 0$ ns, when the edge excitation has not yet arrived [Figs. 2(a)–2(h)] [24].

To analyze the PL peak energy shift, we fit the PL spectra at a given (t, x, y) using a Lorentzian function and obtained the PL peak energy shift $\Delta E(t, x, y)$ at given (t, x, y) (see Appendix B). Consistent with the PL spectra [Figs. 2(a)–2(h)], ΔE exhibits a distinct blueshift around $t \sim 0.5$ ns, coinciding with the arrival of the edge excitation at the measurement point. Notably, the maximum value of ΔE increases as a function of V_{offset} , reaching more than approximately 0.1 meV. Based on this observation, we adopted $V_{\text{offset}} = 0.5$ V for the subsequent experiments discussed below.

While scanning the spatial coordinates x and y around the excitation gate, we captured the t dependence of the PL spectra at $B = 6$ T. Since $B < B_c$, the $\nu = 2/3$ state is in the spin-unpolarized phase. By mapping ΔE as a function of x and y and using t as the time frame, we reconstructed movies illustrating the propagation of the edge and bulk excitations (see SM for movies recorded at $B = 6.5$ and 11.5 T).

A single frame of the movie corresponds to the real-space map of ΔE at a given t [Figs. 3(a)–3(h)]. When the voltage pulse is applied to the excitation gate, the PL from the downstream side of the edge exhibits a blueshift [dark blue region in Fig. 3(b)]. The edge excitation then propagates along the sample edge [dark blue region in Figs. 3(b)–3(e)]. Simultaneously, an excitation near the gate propagates toward the bulk [Figs. 3(b) and 3(c)]. Notably, ΔE near the excitation gate redshifts [red regions in Figs. 3(d)–3(g)], and this negative ΔE region also spreads into the bulk.

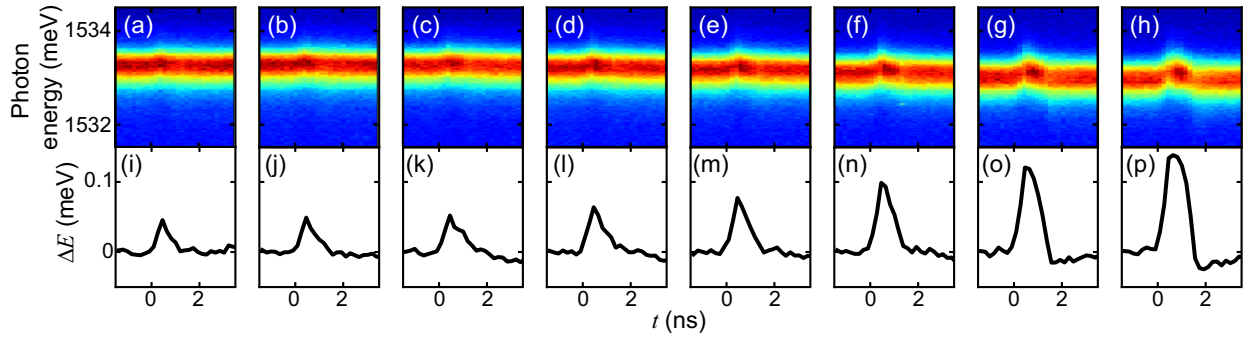


FIG. 2. (a)–(h) Microscopic photoluminescence (PL) spectra at $\nu = 2/3$ and $B = 14$ T as a function of the time delay t between the voltage pulse and the laser pulse for V_{offset} ranging from (a) -0.2 to (h) 0.5 V in 0.1 -V steps. The measurement point corresponds to the downstream side of the edge (Point A in Fig. 1.) (i)–(p) PL peak energy shift, ΔE as a function of t . Each PL spectrum in Figs. 2(a)–2(h) was fitted with a Lorentzian function to determine the PL peak energy at each t . The energy shift ΔE is defined as the deviation of the peak energy from the average peak energy observed during the time interval from $t = -1.38$ to -0.645 ns prior to the arrival of the edge excitation.

To focus on the behavior of bulk excitations, in Fig. 3(i), we plot the dependence of ΔE on both t and the y axis perpendicular to the sample edge [see the dotted arrow in Fig. 3(a)]. Two distinct modes of bulk excitations are clearly observed, corresponding to the strong blueshift and weak redshift regions. The ΔE at $y = 0$ as a function of t exhibits a sharp positive peak at $t \sim 0.5$ ns with an FWHM of ~ 1 ns and a negative peak at $t \sim 2$ – 3 ns with an FWHM of ~ 2 ns [Fig. 3(j)]. Near the excitation gate, the blueshift exceeds 0.2 meV. The blueshift region extends to $y \sim 30$ – 40 μm , while the redshift region remains relatively closer to the excitation gate at $y \sim 20$ μm .

The group velocity v_g of the bulk excitation is determined by the reciprocal of the slope of the peaks in the y - t plot [illustrated by the dotted lines in Fig. 3(j)]. To extract this, we measured both the steepest and flattest slopes,

corresponding to the earlier and later borders of the blueshifted region, respectively. The v_g of the blueshifted peak ranges from 10^4 to 10^5 m/s, whereas that of the redshifted peak is on the order of 10^3 m/s [Fig. 3(j)]. Overall, the v_g of bulk excitations is 1 to 2 orders of magnitude slower than that of the edge excitation [24,25]. By moving the measurement point farther away from the excitation gate, the temporal widths of the blueshift and redshift modes broaden, indicating that the speed of these modes undergoes dispersion. Because the bulk excitations can be seen to spread isotropically in the movies (SM_movie1a.gif and SM_movie1b.gif) and Figs. 3(a)–3(h), we focus on only the velocity in the y direction.

More information about the bulk excitations can be obtained by defining the penetration length l_p as the distance along the y direction from $y = 0$ to the point

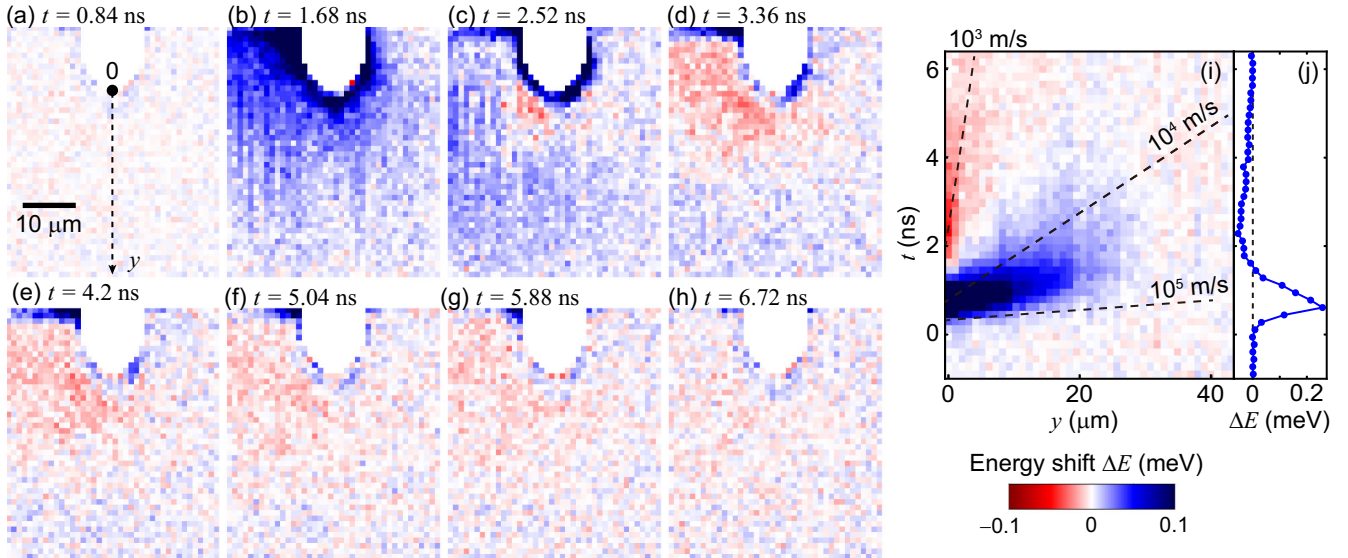


FIG. 3. (a)–(h) Real-space mapping of the energy shift ΔE captured for several t (see SM movies). (i) ΔE dependence both on the spatial position along the y axis [see Fig. 3(a)] and t . (j) ΔE at $y = 0$. All the data shown in Fig. 3 was measured at $B = 6$ T with $V_{\text{offset}} = 0.5$ V.

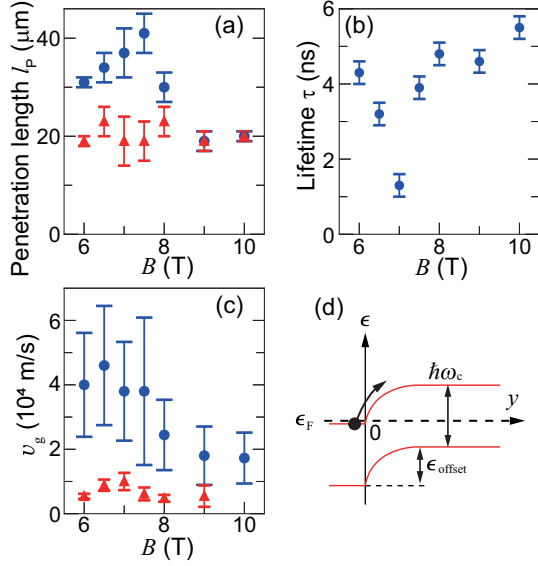


FIG. 4. (a) Dependence of penetration length l_p on B . The blue and red markers represent bulk excitations where blueshifts and redshifts were observed, respectively. (b) Dependence of lifetime τ on B . (c) Dependence of v_g on B . (d) Schematic illustration of the band diagram of the QW. ϵ and ϵ_F denote the energy of electrons and Fermi energy, respectively. The region $y < 0$ corresponds to the area beneath the excitation gate, and ϵ_{offset} represent the offset energy induced by V_{offset} .

where the excitation disappears and the lifetime τ as the time it takes for the excitation to vanish. Thus, $v_g \neq l_p/\tau$. To study l_p and τ , we measured the y and t dependence of the PL spectra at several B ranging from 6 to 10 T (data not shown). By fitting the experimental data at these B values, we obtained ΔE (see Fig. S1). From the y - t dependence at each B , we determined the B dependence of l_p , τ , and v_g , including error estimates, as shown in Figs. 4(a)–4(c) (see SM for details).

Here, we discuss the mechanism of the bulk excitation at the gate [Fig. 4(d)]. The capacitance C of the excitation gate expressed in units of n_e is given by $\epsilon\epsilon_0/ed \sim 3.9 \times 10^{11} \text{ cm}^{-2}/\text{V}$ (see Fig. S3). When $V_{\text{offset}} = 0.5 \text{ V}$ is applied to the excitation gate, the electron density under the gate increases by $\Delta n_e \sim 2 \times 10^{11} \text{ cm}^{-2}$. Since the density of states of the 2DEG is constant as a function of energy, the energy offset ϵ_{offset} induced by V_{offset} can be estimated using $\epsilon_{\text{offset}} = \pi\hbar^2\Delta n_e/m^*$ [34] to be $\epsilon_{\text{offset}} \sim 7 \text{ meV}$ for $\Delta n_e \sim 2 \times 10^{11} \text{ cm}^{-2}$. When the bulk is at $\nu = 2/3$ at $B = 6 \text{ T}$ (10 T), the local electron density under the excitation gate increases to $\sim 3 \times 10^{11} \text{ cm}^{-2}$ ($\sim 3.6 \times 10^{11} \text{ cm}^{-2}$) due to V_{offset} , causing the local ν to increase to ~ 2 (~ 1.5). Similarly, a pulse amplitude of $V_0 = 0.2 \text{ V}$ results in an energy change of $\epsilon_0 \sim 3 \text{ meV}$. The electrons near the edge can be excited to higher Landau levels because the potential change induced by the voltage pulse (Fig. 5) is of the same order as the Landau level spacing, which is $\sim 10 \text{ meV}$ (17 meV) at $B = 6 \text{ T}$ (10 T).

The dispersion relation of the magnetoplasmon is given by: $\omega_{\text{mp}}(k) = \sqrt{\omega_c^2 + \omega_p(k)^2}$, where $\omega_p(k) = \sqrt{n_e e^2 k / 2\epsilon\epsilon_0 m^*}$ is the frequency of the surface plasmon for the 2DEG. Here, ϵ is the relative permittivity of GaAs and ϵ_0 is the vacuum permittivity [26,35–38]. Since $\omega_p(k)$ squared is linear in k , v_g can be derived from the expansion $\omega_{\text{mp}}(k) = \omega_c + \omega_p(k)^2/2\omega_c + O(k^2)$ as [39]

$$v_g = \left. \frac{\partial \omega_{\text{mp}}(k)}{\partial k} \right|_{k \sim 0} = \frac{\nu e^2}{4\epsilon\epsilon_0 \hbar}. \quad (2)$$

Apart from the environmental factor of ϵ , v_g is determined by fundamental physical constants, similarly to the quantization of Hall resistivity, and depends only on ν . Notably, v_g remains unaffected by changes in B , provided that the n_e is adjusted to maintain constant ν . Taking $\epsilon = \epsilon(\omega)$ as the low-frequency limit of the relative permittivity, with $\epsilon(0) = 12.4$ at $\sim 50 \text{ mK}$ [41], we estimate $v_g \sim 5.9 \times 10^4 \text{ m/s}$. This value is consistent with the experimental results, where $v_g \sim 1\text{--}6 \times 10^4 \text{ m/s}$ [Fig. 4(c)].

Since magnetoplasmons arise from mixing between adjacent Landau levels, they provide insights into electron-hole symmetry breaking. If this mixing is neglected, two perspectives on the $\nu = 2/3$ state are related by symmetry: (A) holes form a $\nu = 1/3$ state on the fully filled $\nu = 1$ “vacuum” state of electrons (known as hole-conjugate picture) and (B) electrons form a $\nu = 2/3$ state on the empty $\nu = 0$ vacuum state. These perspectives, (A) and (B), are closely linked to edge models [22]. Magnetoplasmons distinguish these states: the v_g of (A) is half that of (B). Despite the absence of explicit B dependence in Eq. (2), the experimentally observed v_g exhibits slight dependence on B [Fig. 4(c)], which divides the data into two distinct regions: a faster v_g ($\sim 4 \times 10^4 \text{ m/s}$) for $B < 7.5 \text{ T}$ and a slower v_g ($\sim 2 \times 10^4 \text{ m/s}$) for $B > 8 \text{ T}$. The suppression of v_g with increasing B suggests that the hole-conjugate picture (A), which predicts $v_g \sim 3 \times 10^4 \text{ m/s}$, becomes valid when $B > 8 \text{ T}$.

In addition to v_g , there is a possibility that l_p and τ are also related to the edge models. The observed τ remains relatively constant ($\sim 4\text{--}5 \text{ ns}$) over a wide range of B except near 7 T [Fig. 4(b)], which is close to $B_c = 7.5 \text{ T}$. At $B \sim B_c$ it is known that the spin-polarized and spin-unpolarized phases are degenerate [29–32]. In this regime, “edge” states form at domain boundaries between different spin phases due to the exchange interaction, which induces an energy barrier at the boundaries [31,32]. The exchange-energy-induced edge is gapless, allowing bulk excitations to excite these edges. Consequently, the lifetime of the bulk excitation itself shortens near B_c . We note that although τ decreases, l_p slightly increases at B_c [Fig. 4(a)]. This suggests that l_p is not solely determined by the magnetoplasmon but also includes contributions from the edge at domain boundaries.

The propagation velocity of the redshift mode is on the order of 10^3 m/s and is insensitive to the magnetic field. These characteristics limit its interpretation. This mode resembles a strain pulse composed of coherent acoustic phonons in GaAs, which have a group velocity of $\sim 5 \times 10^3$ m/s [42]. It has been reported that such a mode can be excited through the thermal expansion of solids triggered by a picosecond light pulse [27]. In our system, the voltage pulse applied to the gate may induce Joule heating through the magnetoplasmon excitations, which locally increases the temperature and leads to thermal expansion and redshift of the trion PL.

In summary, we electrically excited both the bulk and edge using a voltage pulse and captured spacetime-resolved images of the bulk excitation dynamics. Our findings show that the primary bulk excitations can be explained by magnetoplasmons, while the secondary excitations correspond to a strain pulse. The magnetoplasmons propagating in the bulk, together with those localized at the edge, fully span the two polarization degrees of freedom of the gauge field. Consequently, magnetoplasmons serve as key collective modes that can entangle the bulk and edge. Meanwhile, strain modifies the geometry of the 2DEG. We have reported experimental observations of bulk-edge coupled magnetoplasmon modes and specific propagation features, which support the proposed interpretation and open the door for testing high-energy physics ideas in an experimentally controllable setting. These experiments could include studies of a solid-state simulator of brane-world cosmology using a quantum Hall system, the holographic principle [43], and bulk-edge correspondence, as exemplified by the AdS/CFT correspondence [44,45].

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Data availability—The data that support the findings of this Letter are not publicly available upon publication because it is not technically feasible and/or the cost of preparing, depositing, and hosting the data would be prohibitive within the terms of this research project. The data are available from the authors upon reasonable request.

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- radiate out of the 2DEG as a Landau emission, causing the magnetoplasmon to become unstable [40].
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End Matter

Appendix A: Experimental details—In this section, we provide the experimental details. A mode-locked Ti:sapphire laser with a central wavelength of 790 nm and an FWHM of approximately 7 nm (1.5694 eV with $\sigma \sim 7$ meV) was used as the light source. The laser-emitted pulses are approximately 1 ps long with a 13-ns repetition period. The laser beam was guided to the millikelvin region of the dilution refrigerator via a polarization-maintaining single-mode fiber and focused onto the sample using an objective lens. The σ^- polarized PL was selectively collected using optics located at the millikelvin region, transmitted through a multimode fiber, and subsequently analyzed using a monochromator and CCD detector [31]. The measurement point, which corresponds to the focal point of the microscope, was freely movable across the sample using piezoelectric scanners. The time resolution of the stroboscopic PL measurement was approximately 300 ps. For more details, refer to the experimental techniques described in [24,25].

The light and dark gray regions in Fig. 1 correspond to the deposited Au electrodes and GaAs surface, respectively. The excitation gate is connected to an arbitrary waveform generator (AWG) and a dc voltage source, which provides an offset voltage V_{offset} to the pulse. The two electrodes connected to the ground and the excitation gate form a coplanar waveguide.

Appendix B: PL spectra and PL peak energy shift—To analyze the PL peak energy shift, we fit the PL spectra at a given (t, x, y) using a Lorentzian function,

$$L(E; E_{\text{peak}}, \gamma, A) = \frac{A}{(E - E_{\text{peak}})^2 + \gamma^2}, \quad (\text{B1})$$

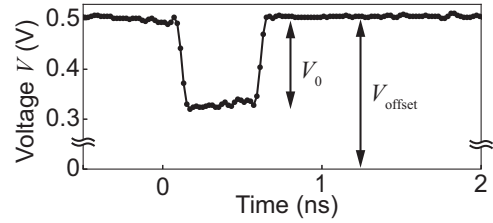


FIG. 5. Voltage waveform applied to the excitation gate, as measured by a 12.5 GHz bandwidth oscilloscope directly connected to AWG and the dc source. The interval between the measurement points is 20 ps. V_0 denotes the amplitude of the square pulse, with a duration of 0.5 ns.

where E , E_{peak} , A , and γ represent the photon energy, the central energy of the spectrum, the amplitude, and the FWHM, respectively. In this analysis, the fitted E_{peak} and A correspond to the estimated PL peak energy and intensity, respectively. We define the average peak energy $\tilde{E}_{\text{peak},0}$ as the mean of five spectra captured before the arrival of the edge excitation. For Figs. 2(i)–2(p), $\tilde{E}_{\text{peak},0}$ is calculated by averaging the spectra from $t = -1.38$ to -0.645 ns. The PL peak energy shift $\Delta E(t, x, y)$ at a given (t, x, y) is then determined using

$$\Delta E(t, x, y) = E_{\text{peak}}(t, x, y) - \tilde{E}_{\text{peak},0}(x, y). \quad (\text{B2})$$